

## MM74C164 8-Bit Parallel-Out Serial Shift Register

### General Description

The MM74C164 shift registers are a monolithic complementary MOS (CMOS) integrated circuit constructed with N- and P-channel enhancement transistors. These 8-bit shift registers have gated serial inputs and clear. Each register bit is a D-type master/slave flip-flop. A high-level input enables the other input which will then determine the state of the flip-flop.

Data is serially shifted in and out of the 8-bit register during the positive going transition of clock pulse. Clear is independent of the clock and accomplished by a low level at the clear input. All inputs are protected against electrostatic effects.

### Features

- Supply voltage range: 3V to 15V
- Tenth power TTL compatible: drive 2 LPTTL loads
- High noise immunity:  $0.45 V_{CC}$  (typ.)
- Low power: 50 nW (typ.)
- Medium speed operation: 0.8 MHz (typ.) with 10V supply

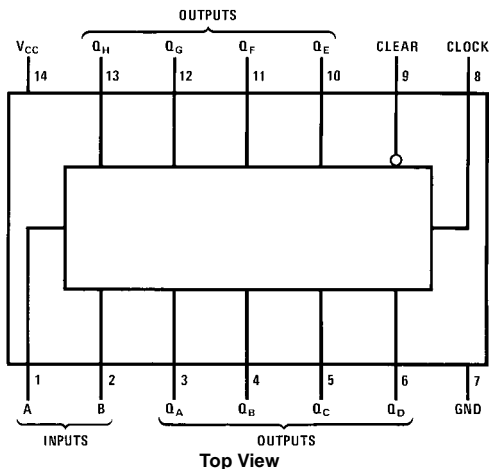
### Applications

- Data terminals
- Instrumentation
- Medical electronics
- Alarm systems
- Industrial electronics
- Remote metering
- Computers

### Ordering Code:

Order Number	Package Number	Package Description
MM74C164M	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
MM74C164N	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

### Connection Diagram



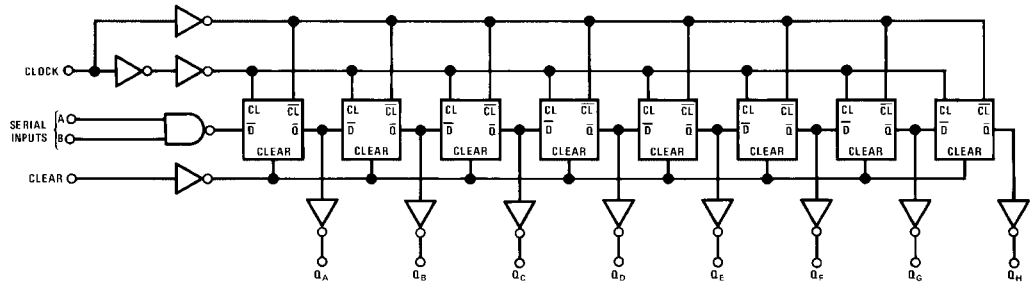
### Truth Table

**Serial Inputs A and B**

Inputs		Output
$t_n$		$t_{n+1}$
A	B	$Q_A$
1	1	1
0	1	0
1	0	0
0	0	0

MM74C164

### Block Diagram



## Absolute Maximum Ratings (Note 1)

Voltage at Any Pin	-0.3V to $V_{CC} + 0.3V$
Operating Temperature Range	-55°C to +125°C
Storage Temperature Range	-65°C to +150°C
Absolute Maximum $V_{CC}$	18V
Power Dissipation ( $P_D$ )	
Dual-In-Line	700 mW
Small Outline	500 mW
Operating $V_{CC}$ Range	3V to 15V
Lead Temperature (soldering, 10 seconds)	260°C

**Note 1:** "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

## DC Electrical Characteristics

Min/Max limits apply across temperature range unless otherwise noted

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>CMOS TO CMOS</b>						
$V_{IN(1)}$	Logical "1" Input Voltage	$V_{CC} = 5V$ $V_{CC} = 10V$	3.5 8.0			V
$V_{IN(0)}$	Logical "0" Input Voltage	$V_{CC} = 5V$ $V_{CC} = 10V$			1.5 2.0	V
$V_{OUT(1)}$	Logical "1" Output Voltage	$V_{CC} = 5V, I_O = -10 \mu A$ $V_{CC} = 10V, I_O = -10 \mu A$	4.5 9.0			V
$V_{OUT(0)}$	Logical "0" Output Voltage	$V_{CC} = 5V, I_O = +10 \mu A$ $V_{CC} = 10V, I_O = +10 \mu A$			0.5 1.0	V
$I_{IN(1)}$	Logical "1" Input Current	$V_{CC} = 15V, V_{IN} = 15V$		0.005	1.0	$\mu A$
$I_{IN(0)}$	Logical "0" Input Current	$V_{CC} = 15V, V_{IN} = 0V$	-1.0	-0.005		$\mu A$
$I_{CC}$	Supply Current	$V_{CC} = 15V$		0.05	300	$\mu A$
<b>CMOS TO LPTTL INTERFACE</b>						
$V_{IN(1)}$	Logical "1" Input Voltage	$V_{CC} = 4.75V$	$V_{CC} - 1.5$			V
$V_{IN(0)}$	Logical "0" Input Voltage	$V_{CC} = 4.75V$			0.8	V
$V_{OUT(1)}$	Logical "1" Output Voltage	$V_{CC} = 4.75V, I_O = -360 \mu A$	2.4			V
$V_{OUT(0)}$	Logical "0" Output Voltage	$V_{CC} = 4.75V, I_O = 360 \mu A$			0.4	V
<b>OUTPUT DRIVE (See Family Characteristics Data Sheet) (Short Circuit Current)</b>						
$I_{SOURCE}$	Output Source Current	$V_{CC} = 5V, V_{IN(0)} = 0V$ $T_A = 25^\circ C, V_{OUT} = 0V$	-1.75			mA
$I_{SOURCE}$	Output Source Current	$V_{CC} = 10V, V_{IN(0)} = 0V$ $T_A = 25^\circ C, V_{OUT} = 0V$	-8.0			mA
$I_{SINK}$	Output Sink Current	$V_{CC} = 5V, V_{IN(1)} = 5V$ $T_A = 25^\circ C, V_{OUT} = V_{CC}$	1.75			mA
$I_{SINK}$	Output Sink Current	$V_{CC} = 10V, V_{IN(1)} = 10V$ $T_A = 25^\circ C, V_{OUT} = V_{CC}$	8.0			mA

## AC Electrical Characteristics (Note 2)

$T_A = 25^\circ\text{C}$ ,  $C_L = 50\text{ pF}$ , unless otherwise noted

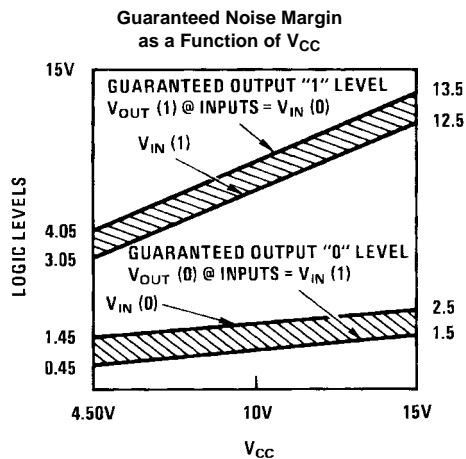
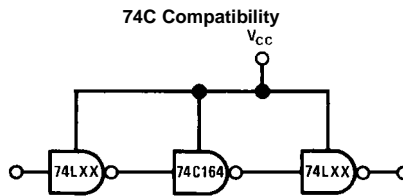
Symbol	Parameter	Conditions	Min	Typ	Max	Units
$t_{pd1}$	Propagation Delay Time to a Logical "0" or a Logical "1" from Clock to Q	$V_{CC} = 5\text{V}$ $V_{CC} = 10\text{V}$		230 90	310 120	ns
$t_{pd0}$	Propagation Delay Time to a Logical "0" from Clear to Q	$V_{CC} = 5\text{V}$ $V_{CC} = 10\text{V}$		280 110	380 150	ns
$t_S$	Time Prior to Clock Pulse that Data Must be Present	$V_{CC} = 5\text{V}$ $V_{CC} = 10\text{V}$	200 80	110 30		ns
$t_H$	Time After Clock Pulse that Data Must be Held	$V_{CC} = 5\text{V}$ $V_{CC} = 10\text{V}$	0 0	0 0		ns
$f_{MAX}$	Maximum Clock Frequency	$V_{CC} = 5\text{V}$ $V_{CC} = 10\text{V}$	2.0 5.5	3 8		MHz
$t_W$	Minimum Clear Pulse Width	$V_{CC} = 5\text{V}$ $V_{CC} = 10\text{V}$		150 55	250 90	ns
$t_r, t_f$	Maximum Clock Rise and Fall Time	$V_{CC} = 5\text{V}$ $V_{CC} = 10\text{V}$	15 5			$\mu\text{s}$
$C_{IN}$	Input Capacitance	Any Input (Note 3)		5		pF
$C_{PD}$	Power Dissipation Capacitance	(Note 4)		140		pF

**Note 2:** AC Parameters are guaranteed by DC correlated testing.

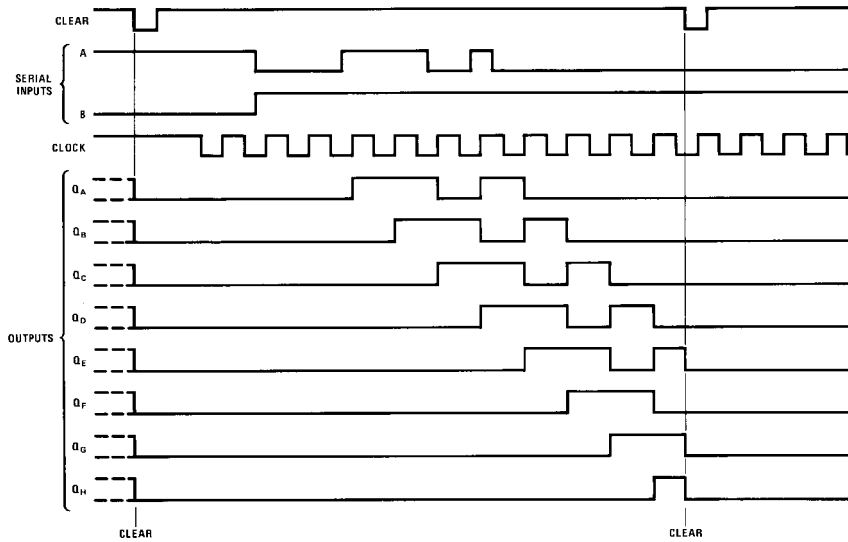
**Note 3:** Capacitance is guaranteed by periodic testing.

**Note 4:**  $C_{PD}$  determines the no load AC power consumption of any CMOS device. For complete explanation see Family Characteristics application note AN-90.

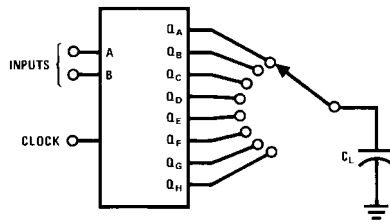
## Typical Applications



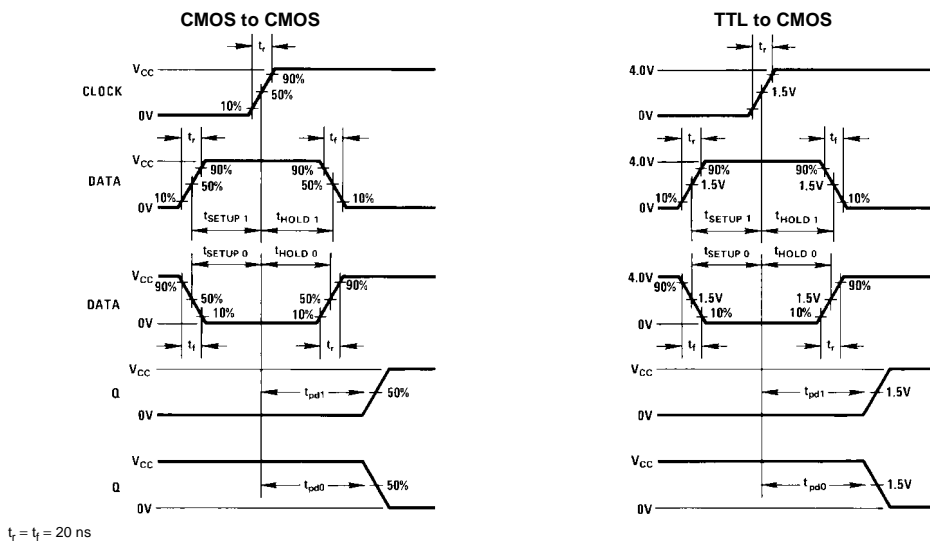
### Logic Waveform



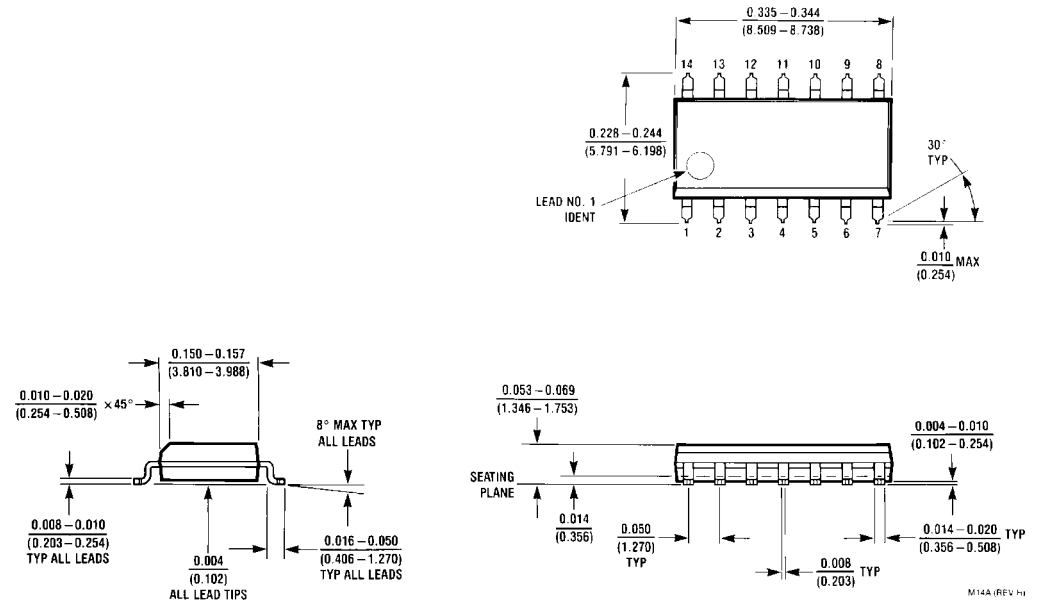
### AC Test Circuit



### Switching Time Waveforms



**Physical Dimensions** inches (millimeters) unless otherwise noted



**14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Package Number M14A**

**Physical Dimensions** inches (millimeters) unless otherwise noted (Continued)



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